


<b>Search Notes</b>  	<b>Application/Control No.</b>  10711451	<b>Applicant(s)/Patent Under Reexamination</b>  BEDNASZ, KENNETH M.
	<b>Examiner</b>  TRI H PHAN	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
455	115.4, 154.1-160-1, 226.4	3/25/2008	TP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPT, JPO, EPO, FPRS, DWPI) - see text search history printout.	3/25/2008	TP
Frank Duong (consulted search class 455)	3/24/2008	TP
Inventorship search	3/24/08	TP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Interference search history printout.		3/25/2008	TP